


<b>Search Notes</b>  	<b>Application/Control No.</b>  10813015	<b>Applicant(s)/Patent Under Reexamination</b>  FAHEY, JED W.
	<b>Examiner</b>  Brian-Yong S Kwon	<b>Art Unit</b>  1614

SEARCHED			
Class	Subclass	Date	Examiner
514	42, 514, 23	03/06/08	bk

SEARCH NOTES		
Search Notes	Date	Examiner
Updated STN, EAST, NPL	03/06/08	bk
Updated (Continuity Data, Inventor Name)		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	42, 514, 23	03/06/08	bk